Attorney Docket No. **62004-1950**

Serial No. **09/995,161**

INFORMATION DISCLOSURE CITATION

Applicant Dalmia, et al.

(Use several sheets if necessary) Filing Date 11/26/01 Group 2811

Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing I If Appro		
TTN	A	5,106,461	4 21 92	Volfson, et al.	205	125			
1	В	5,247,377	9 21 93	Omeis, et al.	359	76			
	С	5,323,128	6 21 94	Ishizaki, et al.	333	204			
	D	5,349,314	9/20/94	Shimizu, et al.	333	204			
	E	5,373,271	12 13 94	Hirai, et al.	333	205			
	F	5,396,201	5 7 95	lshizaki, et al.	333	204			
	G	5,416,454	5′16.95	McVeety	333	204			
	Н	5,497,337	3′5′96	Ponnapalli, et al.	364	489			
•	ī	5,517,751	5/21/96	Bross, et al.	29	830			
TIN	J	5,545,916	8 13 96	Koullias	257	531			
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							Yes	No	
FIN	К	WO 01 97582 A1	12/20/01	Japan				X	
FIN	L	EP 0 506 476·B1	3 27 92	Great Britain			X		
TIN	М	EP 0 510 971 B1	4 23 92	Great Britain			X		
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TTN	N ·			ation in Low-Polymer Dielectrics 4.4 Preprint, San Francisco, CA		ature Stress.	1999 MR	as .	
Ac 1	0	"NASA SBIR Successes." http://sbir.gsfc.nasa.gov/SBIR/successes/Stratasoft/110text.html No DATE							
FIN	P	Flexible Printed Circuit –	YFLEX." <u>http</u>	:/www.yamaichi.us/yflex.ht	ı <u>ml</u>	VO DATE	É		
	Q	Wang, et al., "A Full-Wave	Analysis Mod	el for Uniplanar Circuits with Lun	iped Elements."	1EEE Transa	ictions of		
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TIN	R	5,559,360	9 24 96	Chiu, et al.		257	531		
1	S	5.635.892	6 3 97	Ashby, et al.		336	200		
	Т	5,654,681	8 5 97	Ishizaki, et al.		333	204		
	U	5.668.511	9 16 97	Furutani, et al.		333	204		
	V	5.679.414	10 21 97	Akashi, et al.		428	l		
	w	5.716.663	2/10/98	Capote, et al.		427	96		
	Х	5,719,354	2/17.98	Jester, et al.		174	255		
	Y	5,719,539	2 17 98	lshizaki, et al.		333	204		
þ	Z	5,720,898	2/24/98	Nohira, et al.		252	299.01		
TTN	AA	5.770,986	6/23/98	Tonegawa, et al.		333	204		
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	11	OTHER DOCU	MENTS (Includ	ling Author, Title, D	ate, Pertinent	Pages, etc	.)		
									
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Applicant Dalmia, et al.

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TIN	BB	5.801,100	9/1/98	Lee, et al.		438	678		
1	CC 5.818.313		10 6 98 Estes, e	Estes, et al.		333	262		
	DD	5,844,299	12-1 98	Merrill, et al.	7 Ch 1 S 2003 S	257	531		
	EE	5,917,244	6 29 99	Lee, et al.	, je	257	762		
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	GG	6,008,102	12 28 99	Alford, et al.		438	381		
	нн	6,026.286	2 15′00	Long		455	327		
	II	6.040.226	3 21 00	Wojnarowski, et al.		438	381		
1	11	6,051,289	4/18/00	Tsujimoto, et al.		428	1		
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1	ММ	6,127,905	10 3 00	Horie SER 1 17 2000	. 333	204		
	NN	6,166,799	12 26 00	Kameyama, et al.	349	185	1	
	OO	6,177,853	1 23 01	Nagatomi, et al.	333	204		
	PP	6.191.666	2/20/01	Sheen	333	185		
	QQ	6,191,669	2 20 01	Shigemura	333	204		
	RR	6,225,696	5 1 01	Hathaway, et al.	257	728		
	SS	6,255,714	7 3 01	Kossives, et al.	257	528		
•	777	6,259,148	7′10′01	Barush, et al.	257	531		
TIN	UU	6.261.872	7/17/01	Hathaway, et al.	438	126		
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TTN	VV	6,281,430	8/28/01	Lupo, et al.	136	263		
1	M.M.	6,287,931	9 11 01	Chen	438	381		
	XX	6.303,423	10 16 01	Lin	438	238		
	YY	6.395.374	5 28 02	McAndrew, et al.	428	138		
	ZZ	6,445,266	9/3 /02	Nagatomi, et al.	333	204		
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	вві	2001 0050599	12 13 01	Maekawa, et al.	333	134	12 27	00
	CCI	2002 0008301	1 '24 '02	Liou, et al.	257	531	12 15	98
b	DD1	2002/0048930	4/25/02	Lin	438	622	10.9 01	
TTN	EEI	2002/0064701	5/30/02	Hand, et al.	429	34	911 () [
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<u> </u>		Document Number	Date	Country	Class	Subclass	Translation	
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TIN.	FFI	2002 0074158	6 20 02	St. Lawrence, et al.		174	258	12 13	01
1	661	2002 0064922	5′30′02	Lin		438	381	10.3 ()]
. 3 S 200	знії	2002 0076538	6/20/02	St. Lawrence, et al.		428	209	1240)1
	11,5	2002 0081433	6 27 02	Connelly, et al.		428	458	680	1
THN	ا لالا	2002 0158305	10 31 02	Dalmia, et al.	· . · · .	257	531	11 26	01
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